## Applicant(s)/Patent Under Reexamination 10/699,839 CHANG ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Mai-Huong Tran 2818

Application/Control No.

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,893,936	05-2005	Chen et al.	438/407
	В	US-			
	С	US-			
	D	US-			
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	F	US-			
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	J	US-			
	к	US-			
	L	US-			
	М	US-			

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## NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.